Buffers with open-drain outputs Rev. 7 — 4 July 2012

Product data sheet

General description 1.

The 74LVC2G07 provides two non-inverting buffers.

The output of this device is an open drain and can be connected to other open-drain outputs to implement active-LOW wired-OR or active-HIGH wired-AND functions.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

Schmitt trigger action at all inputs makes the circuit tolerant for slower input rise and fall time.

This device is fully specified for partial power-down applications using I_{OFF}. The I_{OFF} circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

Features and benefits 2.

- Wide supply voltage range from 1.65 V to 5.5 V
- 5 V tolerant input/output for interfacing with 5 V logic
- High noise immunity
- Complies with JEDEC standard:
 - JESD8-7 (1.65 V to 1.95 V)
 - JESD8-5 (2.3 V to 2.7 V)
 - JESD8-B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- -24 mA output drive (V_{CC} = 3.0 V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Inputs accept voltages up to 5 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



3. Ordering information

Table 1.Ordering information

Type number	Package						
	Temperature range	Name	Description	Version			
74LVC2G07GW	–40 °C to +125 °C	SC-88	plastic surface-mounted package; 6 leads	SOT363			
74LVC2G07GV	–40 °C to +125 °C	TSOP6	plastic surface-mounted package (TSOP6); 6 leads	SOT457			
74LVC2G07GM	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body $1 \times 1.45 \times 0.5$ mm	SOT886			
74LVC2G07GF	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body $1 \times 1 \times 0.5$ mm	SOT891			
74LVC2G07GN	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body 0.9 \times 1.0 \times 0.35 mm	SOT1115			
74LVC2G07GS	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body $1.0 \times 1.0 \times 0.35$ mm	SOT1202			

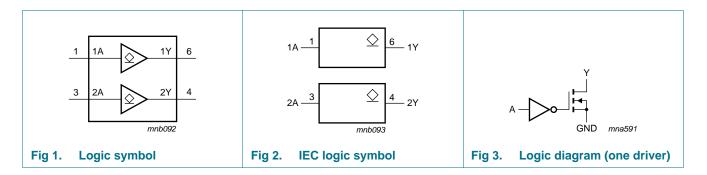
4. Marking

Table 2. Marking

Type number	Marking code ^[1]
74LVC2G07GW	V7
74LVC2G07GV	V07
74LVC2G07GM	V7
74LVC2G07GF	V7
74LVC2G07GN	V7
74LVC2G07GS	V7

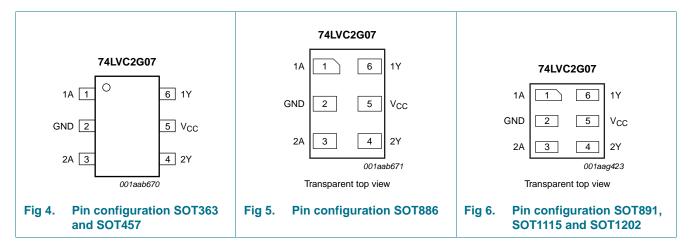
[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

5. Functional diagram



6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3.	Pin description	
Symbol	Pin	Description
1A	1	data input
GND	2	ground (0 V)
2A	3	data input
2Y	4	data output
V _{CC}	5	supply voltage
1Y	6	data output

7. Functional description

Table 4.Function table^[1]

Input nA	Output nY
L	L
Н	Z

[1] H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

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8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

				10	,
Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+6.5	V
I _{IK}	input clamping current	V _I < 0 V	-50	-	mA
VI	input voltage		<u>[1]</u> –0.5	+6.5	V
I _{OK}	output clamping current	V _O < 0 V	-50	-	mA
Vo	output voltage	Active mode	<u>[1]</u> –0.5	+6.5	V
		Power-down mode	<u>[1][2]</u> –0.5	+6.5	V
I _O	output current	$V_{O} = 0 V$ to 6.5 V	-	50	mA
I _{CC}	supply current		-	100	mA
I _{GND}	ground current		-100	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to \ +125 \ ^{\circ}C$	<u>[3]</u> _	250	mW

[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] When $V_{CC} = 0 V$ (Power-down mode), the output voltage can be 5.5 V in normal operation.

9. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.65	-	5.5	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	Active mode	0	-	5.5	V
		Power-down mode; $V_{CC} = 0 V$	0	-	5.5	V
T _{amb}	ambient temperature		-40	-	+125	°C
$\Delta t / \Delta V$	input transition rise and	V_{CC} = 1.65 V to 2.7 V	-	-	20	ns/V
	fall rate	V_{CC} = 2.7 V to 5.5 V	-	-	10	ns/V

10. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T _{amb} = -40	0 °C to +85 °C <u>[1]</u>					
V _{IH}	HIGH-level input	$V_{CC} = 1.65 \text{ V} \text{ to } 1.95 \text{ V}$	$0.65 \times V_{CC}$	-	-	V
	voltage	V_{CC} = 2.3 V to 2.7 V	1.7	-	-	V
		V_{CC} = 2.7 V to 3.6 V	2.0	-	-	V
		V_{CC} = 4.5 V to 5.5 V	$0.7\times V_{CC}$	-	-	V
VIL	LOW-level input	V_{CC} = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V
	voltage	V_{CC} = 2.3 V to 2.7 V	-	-	0.7	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	-	-	0.8	V
	V_{CC} = 4.5 V to 5.5 V	-	-	$0.3\times V_{CC}$	V	
V _{OL}	LOW-level output	$V_{I} = V_{IH} \text{ or } V_{IL}$				
	voltage	I_{O} = 100 $\mu\text{A};$ V_{CC} = 1.65 V to 5.5 V	-	-	0.10	V
		$I_0 = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.45	V
		$I_0 = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.30	V
		$I_0 = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.40	V
		$I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.55	V
		$I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.55	V
I	input leakage current	V _I = 5.5 V or GND; V _{CC} = 0 V to 5.5 V	[2] -	±0.1	±5	μΑ
I _{OZ}	OFF-state output current		-	±0.1	±10	μΑ
I _{OFF}	power-off leakage current	V_1 or V_0 = 5.5 V; V_{CC} = 0 V	-	±0.1	±10	μΑ
I _{CC}	supply current	$V_{I} = 5.5 V \text{ or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 V \text{ to } 5.5 V$	-	0.1	10	μA
Δl _{CC}	additional supply current	per pin; V _I = V _{CC} – 0.6 V; I _O = 0 A; V _{CC} = 2.3 V to 5.5 V	[2] _	5	500	μA
CI	input capacitance		-	2.5	-	pF

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T _{amb} = -40	°C to +125 °C					
V _{IH}	HIGH-level input	V _{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
	voltage	V_{CC} = 2.3 V to 2.7 V	1.7	-	-	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2.0	-	-	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	$0.7\times V_{CC}$	-	-	V
V _{IL}	LOW-level input	V _{CC} = 1.65 V to 1.95 V	-	-	$0.35\times V_{CC}$	V
	voltage	V_{CC} = 2.3 V to 2.7 V	-	-	0.7	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	-	-	0.8	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	-	-	$0.3\times V_{CC}$	V
V _{OL}	LOW-level output	$V_{I} = V_{IH} \text{ or } V_{IL}$				
	voltage	I_{O} = 100 μ A; V_{CC} = 1.65 V to 5.5 V	-	-	0.10	V
		I _O = 4 mA; V _{CC} = 1.65 V	-	-	0.70	V
		$I_0 = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_0 = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.60	V
		$I_0 = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.80	V
		$I_0 = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.80	V
I	input leakage current	V _I = 5.5 V or GND; V _{CC} = 0 V to 5.5 V	-	-	±20	μΑ
loz	OFF-state output current		-	-	±10	μΑ
OFF	power-off leakage current	V_{I} or V_{O} = 5.5 V; V_{CC} = 0 V	-	-	±20	μΑ
сс	supply current	$V_{I} = 5.5 V \text{ or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 V \text{ to } 5.5 V$	-	-	40	μA
∆l _{CC}	additional supply current	per pin; V _I = V _{CC} – 0.6 V; I _O = 0 A; V _{CC} = 2.3 V to 5.5 V	-	-	5000	μA

Table 7. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

[1] All typical values are measured at $T_{amb} = 25 \ ^{\circ}C$.

[2] These typical values are measured at V_{CC} = 3.3 V.

11. Dynamic characteristics

Dynamic characteristics Table 8.

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 8.

Symbol	ol Parameter Conditions			-40	°C to +85	S°C	–40 °C to	o +125 ℃	Unit
				Min	Typ <mark>[1]</mark>	Мах	Min	Max	
t _{pd}	propagation delay	nA to nY; see Figure 7	[2]						
		V_{CC} = 1.65 V to 1.95 V		1.0	3.5	6.7	1.0	8.4	ns
		V_{CC} = 2.3 V to 2.7 V		0.5	2.4	4.3	0.5	5.5	ns
		$V_{CC} = 2.7 V$		1.0	2.3	4.2	1.0	5.3	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		0.5	2.6	3.7	0.5	4.7	ns
		V_{CC} = 4.5 V to 5.5 V		0.5	1.5	2.9	0.5	3.7	ns
C _{PD}	power dissipation capacitance	$V_{\rm I}$ = GND to $V_{\rm CC};V_{\rm CC}$ = 3.3 V	<u>[3]</u>	-	6.5	-	-	-	pF

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.8 V, 2.5 V, 2.7 V, 3.3 V and 5.0 V respectively.

[2] t_{pd} is the same as t_{PLZ} and t_{PZL} .

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz;

 $f_o = output frequency in MHz;$

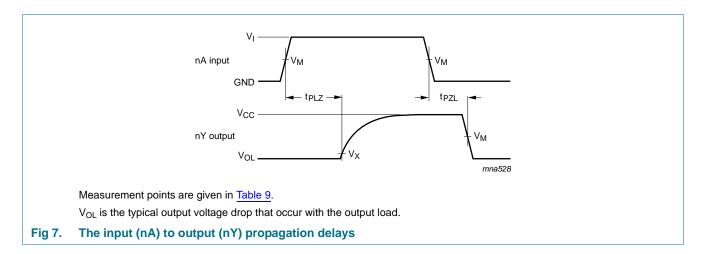
C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

12. Waveforms



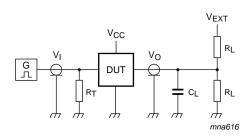
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74LVC2G07

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Table 9. Measurement points					
Supply voltage	Input	Output			
V _{CC}	V _M	V _M	Vx		
1.65 V to 1.95 V	$0.5 imes V_{CC}$	$0.5 imes V_{CC}$	V _{OL} + 0.15 V		
2.3 V to 2.7 V	$0.5\times V_{CC}$	$0.5\times V_{CC}$	V _{OL} + 0.15 V		
2.7 V	1.5 V	1.5 V	V _{OL} + 0.3 V		
3.0 V to 3.6 V	1.5 V	1.5 V	V _{OL} + 0.3 V		
4.5 V to 5.5 V	$0.5\times V_{CC}$	$0.5 imes V_{CC}$	V _{OL} + 0.3 V		



Test data is given in Table 10.

Definitions for test circuit:

R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to the output impedance Z_0 of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

Fig 8. Test circuit for measuring switching times

Table 10. Test data

Supply voltage	Input		Load		V _{EXT}
V _{CC}	VI	t _r , t _f	CL	RL	t _{PZL} , t _{PLZ}
1.65 V to 1.95 V	V _{CC}	\leq 2.0 ns	30 pF	1 kΩ	$2 \times V_{CC}$
2.3 V to 2.7 V	V _{CC}	\leq 2.0 ns	30 pF	500 Ω	$2 \times V_{CC}$
2.7 V	2.7 V	\leq 2.5 ns	50 pF	500 Ω	6 V
3.0 V to 3.6 V	2.7 V	\leq 2.5 ns	50 pF	500 Ω	6 V
4.5 V to 5.5 V	V _{CC}	\leq 2.5 ns	50 pF	500 Ω	$2 \times V_{CC}$

Buffers with open-drain outputs

13. Package outline

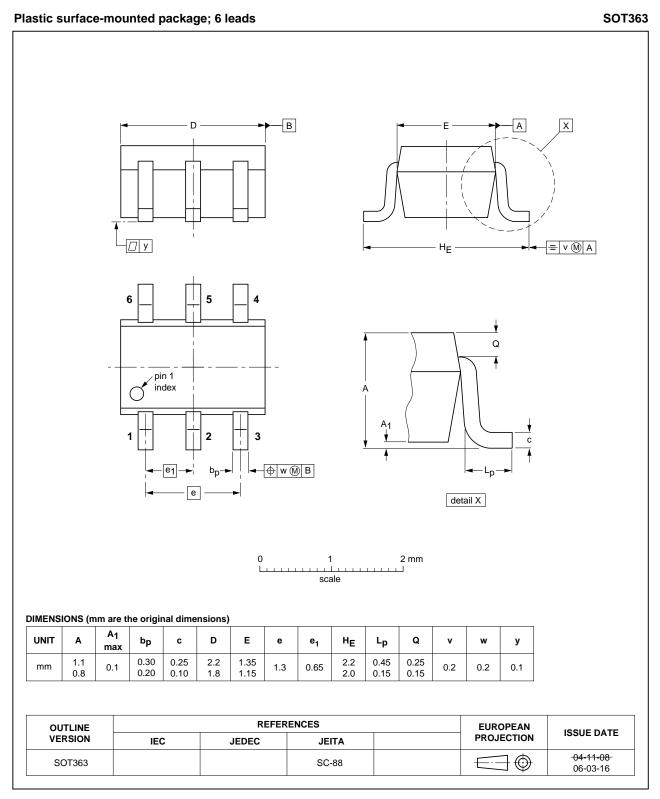


Fig 9. Package outline SOT363 (SC-88)

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74LVC2G07

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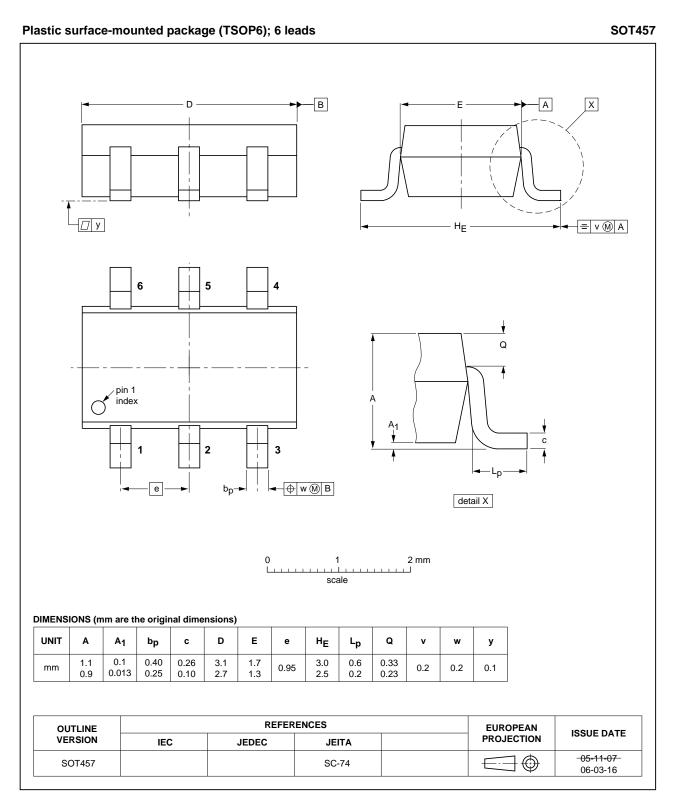


Fig 10. Package outline SOT457 (TSOP6)

Buffers with open-drain outputs

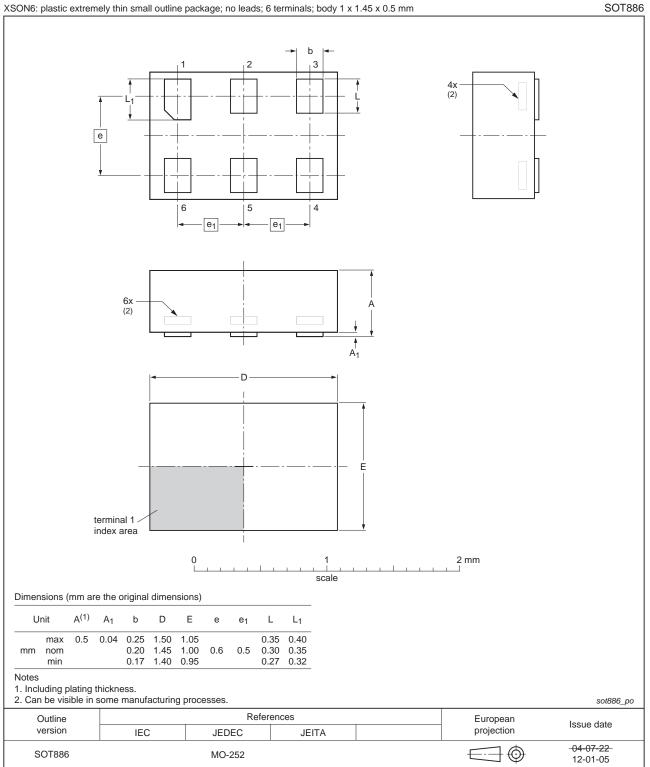


Fig 11. Package outline SOT886 (XSON6)

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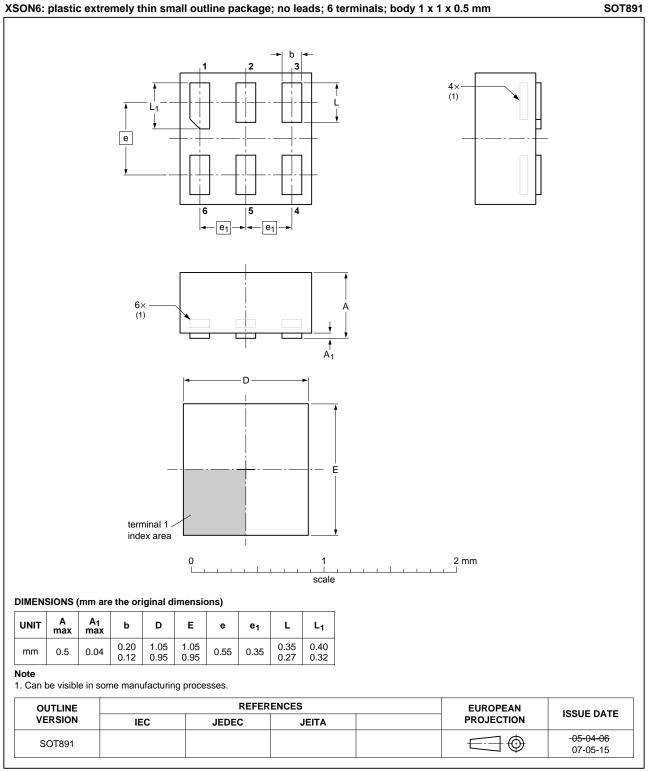
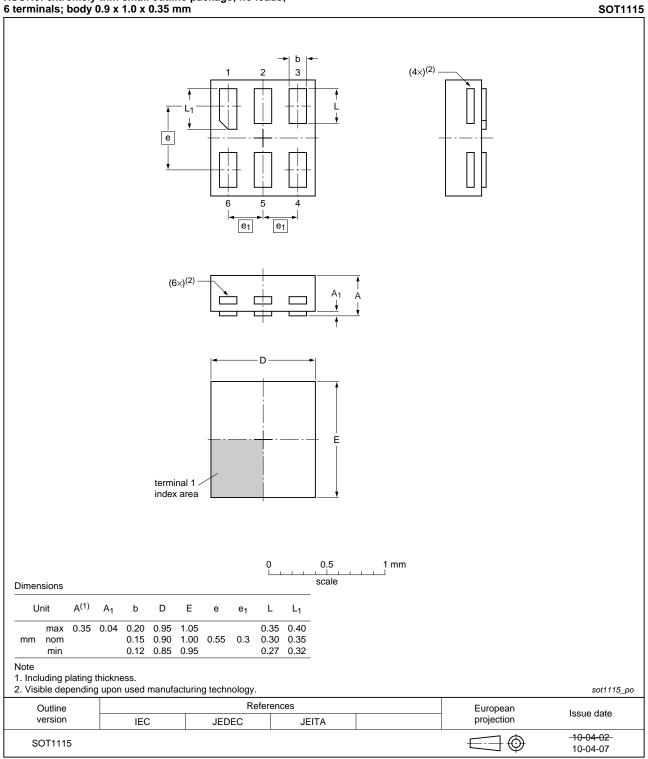


Fig 12. Package outline SOT891 (XSON6)

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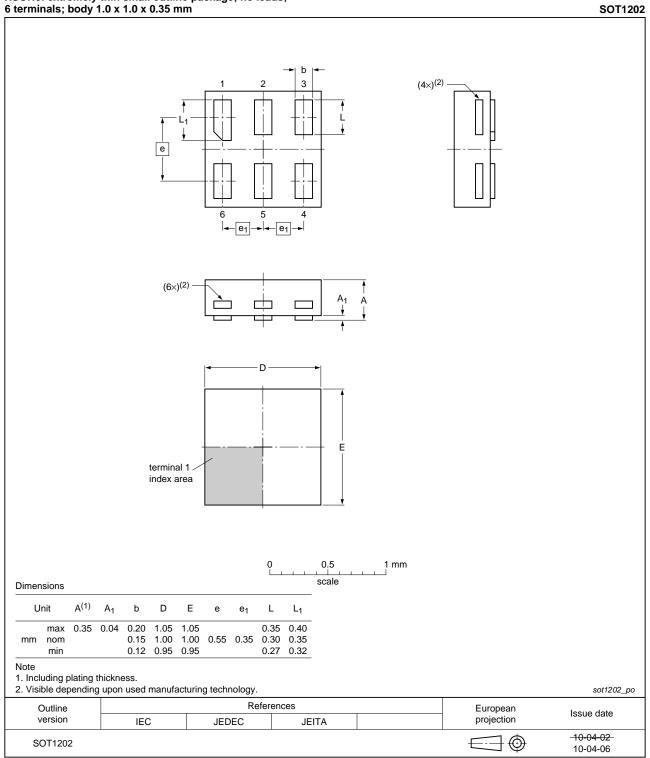


XSON6: extremely thin small outline package; no leads; 6 terminals; body 0.9 x 1.0 x 0.35 mm

Fig 13. Package outline SOT1115 (XSON6)

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XSON6: extremely thin small outline package; no leads; 6 terminals; body 1.0 x 1.0 x 0.35 mm

Fig 14. Package outline SOT1202 (XSON6)

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14. Abbreviations

Table 11. Abbreviations				
Acronym	Description			
CMOS	Complementary Metal Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
MM	Machine Model			
TTL	Transistor-Transistor Logic			

15. Revision history

Table 12. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVC2G07 v.7	20120704	Product data sheet	-	74LVC2G07 v.6	
Modifications:	 Package out 	line drawing of SOT886 (Figure	e 11) modified.		
74LVC2G07 v.6	20111130	Product data sheet	-	74LVC2G07 v.5	
Modifications:	 Legal pages 	updated.			
74LVC2G07 v.5	20100806	Product data sheet	-	74LVC2G07 v.4	
74LVC2G07 v.4	20070521	Product data sheet	-	74LVC2G07 v.3	
74LVC2G07 v.3	20040908	Product data sheet	-	74LVC2G07 v.2	
74LVC2G07 v.2	20040319	Product data sheet	-	74LVC2G07 v.1	
74LVC2G07 v.1	20030825	Product data sheet	-	-	

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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